

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/605,234	CHANG ET AL.	
Examiner Khiem D. Nguyen		Art Unit 2823	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,987,042	01-2006	Beintner et al.	438/241
*	B	US-7,122,439	10-2006	Kwon et al.	438/386
*	C	US-2005/0181557	08-2005	Jakschik et al.	438/246
*	D	US-6,667,503	12-2003	Koike et al.	257/301
*	E	US-6,605,838	08-2003	Mandelman et al.	257/305
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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